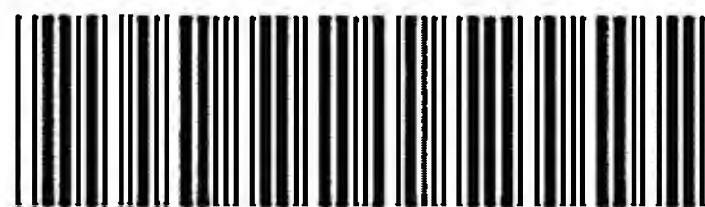


Search Notes



Application/Control No.

10/709,780

Examiner

Thien F. Tran

**Applicant(s)/Patent under
Reexamination**

MCCLURE ET AL.

Art Unit

2811

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)